Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/995,695	WAKAYAMA ET AL.
Examiner	Art Unit
TUAN A. PHAM	2643

SEARCHED				
Class	Subclass	Date	Examiner	
455	333	9/1/2005	РНАМ	
	334			
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375	316			
	345	10/21/2005	PHAM	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	Same As			
	Above			

(INCLUDING SE	DATE	EXMR
		
Consulted with:		
Nguyen Vo	10/20/2005	PHAM
Cong Le (PQT)		
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